

Form PTO-1449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.  
30-5031(4016)

SERIAL NO.  
09/608,709

LIST OF ART CITED BY APPLICANT  
(Use several sheets if necessary)

APPLICANT  
Wang et al.

FILING DATE  
June 30, 2000

GROUP  
1741

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*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
ASB	AA	5,112,468 A	05/92	Weigert et al.			
	AB	5,412,967 A	05/95	Ishihara			
	AC	6,176,944 B1	01/01	Snowman et al.			
ASB	AD	<del>6,043,240</del>		<del>Cole et al.</del>			08/25/98
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	AK						

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FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
ASB	AL	09272970A	10/97	Japan				
	AM	66030549	03/88	Japan				
	AN	0252478A2	01/88	EP				
ASB	AO	0799905A1	03/97	EP				
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

ASB	AQ	*	U. Admon et al., "Microstructure of Electrodeposited Cobalt-Tungsten Thin Films", database HCA on STN, AN 105:28215, EJ. Appl. Phys. (1986) 59(6), 2002-9, abstract, 1 page
ASB	AR	*	S. Vitkova et al., "Texture Correspondences Between the Crystallites of H.C.P. and F.C.C. Phases in Two-Phase Electrolytic of Cobalt and Nickel-Cobalt Alloys", database HCA on STN, AN 84:142489, Electrodeposition Surf. Treat. (1975), 3(4), 225-34 abstract, 1 page
ASB	AS	*	T. Wakiyama, "Magnetic and Crystalline Properties of Hexagonal Cobalt-Iron Alloys", database HCA on STN, AN 79:36474, AIP (Amer. Inst. Phys.), Conf. Proc. (1979) Vol. Date 1972, No. 10 (Pt. 2) 921-40 abstract, 1 page

EXAMINER *C. Phasge* DATE CONSIDERED *3/20/02*

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

*\* no mention*

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APPLICANT  
Honeywell International Inc.FILING DATE  
June 30, 2000GROUP  
~~Unknown~~ 1741

## U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
<i>ASD</i>	AA	5,667,665	9/16/97	Shindo et al.			
	AB	5,810,983	9/22/98	Shindo et al.			
	AC	4,832,810	5/23/89	Nakamura et al.			
<i>ASD</i>	AD	5,282,946	2/1/94	Kinoshita et al.			

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							Yes	No
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	AF	JP1993000001673	6/15/93	Japan				
	AG	JP1995000080830	3/14/95	Japan				
	AH	JP1996000060362	2/23/96	Japan				
<i>ASD</i>	AI	JP1992000357367	12/24/92	Japan				
	AJ	JP1992000357366	12/24/92	Japan				

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

<i>ASD</i>	AK		"Separation of Nickel From Cobalt In Sulphate Medium by Ion Exchange" by L. Rosato, G.B. Harris and R.W. Stanley; paper presented at the 11 <sup>th</sup> AIME Annual Meeting, Dallas Texas; 14-18 February 1982
<i>ASD</i>	AL	X	"Selective Absorption of Copper, Nickel, Cobalt, and Other Transition Metal Ions From Sulfuric Acid Solutions With The Chelating Ion Exchange Resin XFS 4195" by Robert R. Grinstead; Hydrometallurgy, 12 (1984) pp. 387-400; Elsevier Science Publisher B.V., Amsterdam
<i>ASD</i>	AM		"Upgrading the U.S. Cobalt Stockpile Supply"; by P.G. Bennet, J.V. Arwood, and L.D. Redden (no date)
<i>ASD</i>	AN		"Extractive Metallurgy of Nickel & Cobalt"; Edited by G.P. Tyröler and C.A. Landolt; a Publication of the Metallurgical Society, Inc.; pp 505-515 (no date)
<i>ASD</i>	AO		"Experimental Production of High-Purity Cobalt" by K.K. Kershner, F.W. Hoertel, and J.C. Stahl; Reprinted from Bureau of Mines Report of Investigations 5175; January 1956; pp. 1-12
<i>ASD</i>	AP		"Separation of Nickel From Cobalt In Sulphate Medium by Ion Exchange" by L. Rosato, G.B. Harris and R.W. Stanley; paper presented at the 11 <sup>th</sup> AIME Annual Meeting, Dallas Texas; 14-18 February 1982; pp 33-44; published 1984 Elsevier Science Publishers B.V., Amsterdam

EXAMINER

*A. Phasge*

DATE CONSIDERED

3/20/02

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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. 30-5031(4016)	SERIAL NO. 09/608,709
<div style="display: flex; align-items: center; justify-content: center;"> <div style="border: 1px solid black; border-radius: 50%; padding: 10px; text-align: center; margin-right: 10px;"> O I P E JAN 11 2001 PATENT &amp; TRADEMARK OFFICE </div> <div> LIST OF ART CITED BY APPLICANT  (Use several sheets if necessary) </div> </div>				APPLICANT Honeywell International Inc.	
				FILING DATE June 30, 2000	GROUP <u>Unknown</u> 7741

  

U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
A30	AA	3,091,022	5/28/63	Faulkner			
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FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
A30	AM	EP 0 799 905 A1	08.10.1997	EPO			
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	AO						
	AP						
	AQ						

  

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
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